

SSM3J118TU-VB Datasheet

P-Channel 20 V (D-S) MOSFET

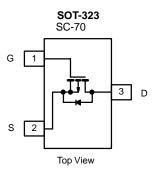
PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^c	Q _g (Typ.)			
- 20	0.080 at V _{GS} = - 4.5 V	- 3.1	4.3 nC			
- 20	0.100 at V _{GS} = - 2.5 V	- 2.3	4.5110			

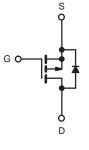
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Load Switch
- DC/DC Converters





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T	A = 25 °C, unless oth	erwise noted)		
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	V
Gate-Source Voltage		V _{GS}	± 12	
	T _C = 25 °C		- 3.1	
Continuous Drain Current ($T_J = 150 \text{ °C}$)	T _C = 70 °C		- 2.1	
Continuous Drain Current $(1) = 150^{\circ}$ C)	T _A = 25 °C		- 1.4 ^{a, b}	
	T _A = 70 °C		- 1.1 ^{a, b}	A
Pulsed Drain Current		I _{DM}	- 6	
Ocational Decis Diale Ocacia	T _C = 25 °C	1-	- 0.4	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 0.3	
	T _C = 25 °C		0.5	
Maximum Dawar Dissinction	T _C = 70 °C	P _D	0.3	w
Maximum Power Dissipation	T _A = 25 °C	'D	0.4 ^{a, b}	vv
	T _A = 70 °C		0.3 ^{a, b}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 50 to 150	<u></u>	
Soldering Recommendations (Peak Temperature)		260		

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Based on T_C = 25 °C.



THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	250	300	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	225	270	C/W	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. Maximum under steady state conditions is 360 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	Symbol	Test conditions	141111.	Typ.	IVIAA.	Unit
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 20			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	VGS = 0 V, ID = 200 µ/V	20	- 14		- mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J	l _D = - 250 μA		2.4		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 0.45	2.1	- 1.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 8 V$	0.10		± 100	nA
Carlo Couros Esanago	-655	$V_{DS} = -20 V, V_{GS} = -20 V$			- 1	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			- 10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 2			A
	D(01)	V _{GS} = - 4.5 V, I _D = - 1.4 A		0.080		Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 1.2 A		0.100		
	20(01)	V _{GS} = - 1.8 V, I _D = - 0.3 A		0.140		
Forward Transconductance ^a	g _{fs}	$V_{DS} = -5 V, I_D = -1.4 A$		5		S
Dynamic ^b	013		L			L
Input Capacitance	C _{iss}			272		pF
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		55		
Reverse Transfer Capacitance	C _{rss}			44		
Total Gate Charge	Qg	V _{DS} = - 10 V, V _{GS} = - 4.5 V, I _D = - 1.4 A		4.3	6.5	nC
				2.7	4.1	
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -2.5 \text{ V}, I_{D} = -1.4 \text{ A}$		0.7		
Gate-Drain Charge	Q _{ad}			1.0		
Gate Resistance	R _q	f = 1 MHz	1.4	7	14	Ω
Turn-On Delay Time	t _{d(on)}			12	20	
Rise Time	t _r	V _{DD} = - 10 V, R _I = 9.1 Ω		20	30	- ns
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 1.1 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		23	35	
Fall Time	t _f			9	18	
Turn-On Delay Time	t _{d(on)}			5	10	
Rise Time	t _r	$V_{DD} = -10 \text{ V}, \text{ R}_{1} = 9.1 \Omega$		10	20	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -1.1 \text{ A}, \text{ V}_{\text{GEN}} = -8 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		18	27	
Fall Time	t _f	, j		7	14	
Drain-Source Body Diode Characterist		·				
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 2.4	
Pulse Diode Forward Current ^a	I _{SM}	-			- 6	A
Body Diode Voltage	V _{SD}	I _F = - 0.7 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}	·		18	27	ns
Body Diode Reverse Recovery Charge	Q _{rr}			7	14	nC
Reverse Recovery Fall Time	t _a	I _F = - 0.7 A, dl/dt = 100 A/μs, T _J = 25 °C		7		
Reverse Recovery Rise Time	t _b			11		ns

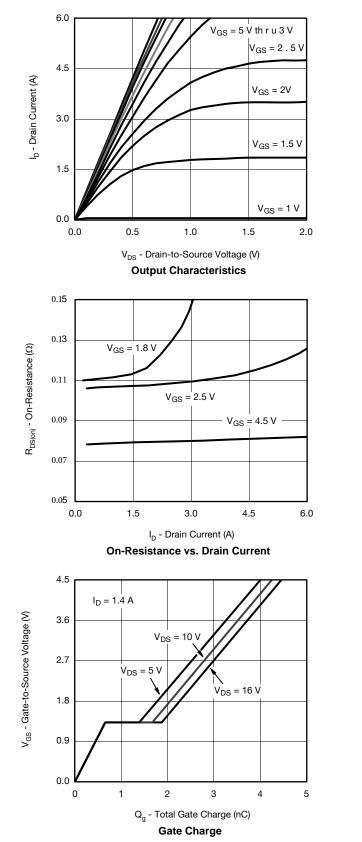
Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

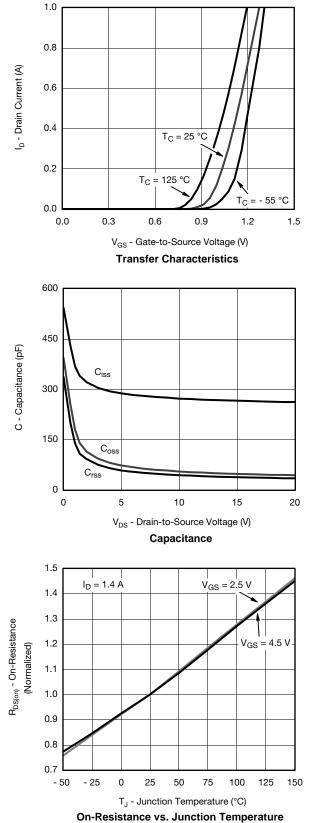
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





I_D = 1.4 A

T_J = 125 °C

 $T_J = 25 \ ^\circ C$

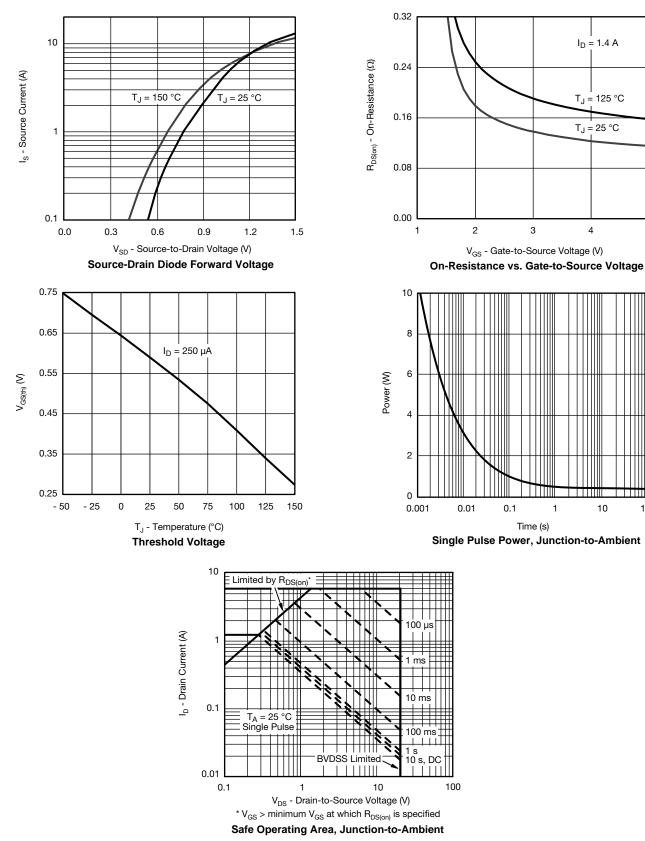
4

1

10

100

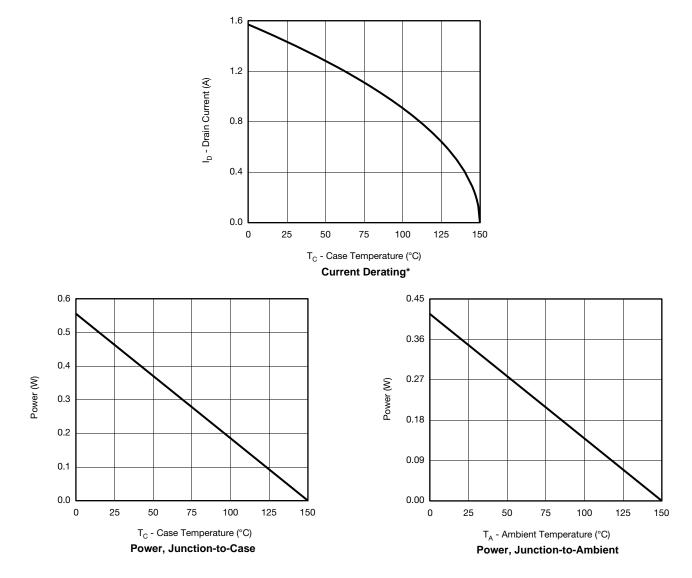
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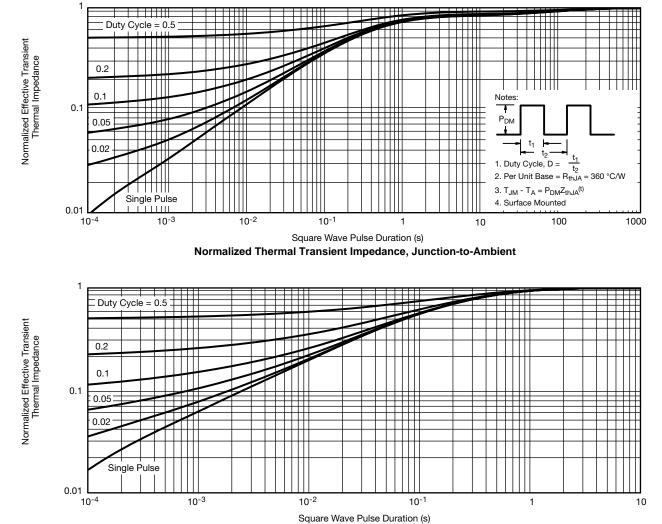
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

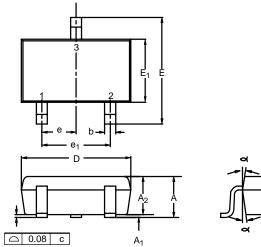
Normalized Thermal Transient Impedance, Junction-to-Foot

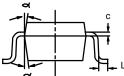
Bsemi

www.VBsemi.com



SC-70: 3-LEADS



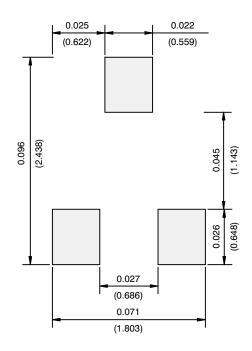


	MILLIMETERS			INCHES		
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.90	-	1.10	0.035	-	0.043
A ₁	I	-	0.10	-	-	0.004
A ₂	0.80	-	1.00	0.031	-	0.039
b	0.25	-	0.40	0.010	-	0.016
С	0.10	-	0.25	0.004	-	0.010
D	1.80	2.00	2.20	0.071	0.079	0.087
E	1.80	2.10	2.40	0.071	0.083	0.094
E ₁	1.15	1.25	1.35	0.045	0.049	0.053
е	0.65BSC			0.026BSC		
e ₁	1.20	1.30	1.40	0.047	0.051	0.055
L	0.10	0.20	0.30	0.004	0.008	0.012
ð	ର୍ 7°Nom			7°Nom		
ECN: S-03946—Rev. C, 09-Jul-01 DWG: 5549						

SSM3J118TU-VB



RECOMMENDED MINIMUM PADS FOR SC-70: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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